

MN54F365-X REV 1A0

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HEX BUFFER/DRIVER WITH 3-STATE OUTPUTS
General Description

The F365 is a hex buffer and line driver designed to be employed as memory and address driver, clock driver and bus-oriented transmitter/receiver.

Industry Part Number

54F365

NS Part Numbers

54F365DMQB

54F365FMQB

54F365LMQB

Prime Die

M365

Processing

MIL-STD-883, Method 5004

Quality Conformance Inspection

MIL-STD-883, Method 5005

Subgrp Description
Temp (°C)

1	Static tests at	+25
2	Static tests at	+125
3	Static tests at	-55
4	Dynamic tests at	+25
5	Dynamic tests at	+125
6	Dynamic tests at	-55
7	Functional tests at	+25
8A	Functional tests at	+125
8B	Functional tests at	-55
9	Switching tests at	+25
10	Switching tests at	+125
11	Switching tests at	-55

Features

- 3-State Buffer Outputs Sink 48 mA
- High Speed
- Bus Oriented

(Absolute Maximum Ratings)

(Note 1)

Storage Temperature	-65 C to +150 C
Ambient Temperature under Bias	-55 C to +125 C
Junction Temperature under Bias	-55 C to +175 C
Vcc Pin Potential to Ground Pin	-0.5V to +7.0V
Input Voltage (Note 2)	-0.5V to +7.0V
Input Current (Note 2)	-30mA to +5.0mA
Voltage Applied to Output in HIGH State (with Vcc=0V)	
Standard Output	-0.5V to Vcc
TRI-STATE Output	-0.5V to +5.5V
Current Applied to Output in LOW State (Max)	twice the rated Iol(mA)

Note 1: Absolute Maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Recommended Operating Conditions

Free Air Ambient Temperature	
Commercial	0 C to +70 C
Military	-55 C to +125 C
Supply Voltage	
Military	+4.5V to +5.5V
Commercial	+4.5V to +5.5V

Electrical Characteristics

DC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)
DC: VCC 4.5V to 5.5V, Temp range: -55C to 125C

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
IIH	Input High Current	VCC=5.5V, VM=2.7V, VINH=5.5V, VINL=0.0V	1, 3	INPUTS		30	uA	1, 2, 3
IBVI	Input High Current	VCC=5.5V, VM=5.5V, VINH=5.5V	1, 3	INPUTS		1.0	uA	1, 2, 3
IBVI2	Input High Current	VCC=0.0V, VM=7.0V, VINH=5.5V, VINL=0.0V	1, 3	INPUTS		100	uA	1, 2, 3
IILX	Input LOW Current	VCC=5.5V, VM=0.5V, VINH=5.5V, VINL=0.0V	1, 3	INPUTS		-20	uA	1, 2, 3
VOLB	Output LOW Voltage	VCC=4.5V, VIL=0.8V, IOH=2.0V, IOLB=48mA, VINH=5.5V	1, 3	OUTPUTS		.55	V	1, 2, 3
VOH3	Output HIGH Voltage	VCC= 4.5V, VIL=0.8V, IOH=-3.0mA, VIH=2.0V, VINH=5.5V	1, 3	OUTPUTS	2.4		V	1, 2, 3
VOHB	Output HIGH Voltage	VCC=4.5V, VIL=0.8V, IOH=-12.0mA, VIH=2.0V, VINH=5.5V	1, 3	OUTPUTS	2.0		V	1, 2, 3
IOS	Short Circuit Current	VCC=5.5V, VINL=0.0V, VINH=5.5V, VM=0.0V	1, 3	OUTPUTS	-100	-225	mA	1, 2, 3
VCD	Input Clamp Diode Voltage	VCC=4.5V, IM=-18mA, VINH=5.5V	1, 3	INPUTS		-1.2	V	1, 2, 3
ICCH	Supply Current	VCC=5.5V, VINL=0.0V, VINH=5.5V	1, 3	VCC		35	mA	1, 2, 3
ICCL	Supply Current	VCC=5.5V, VINL=0.0V, VINH=5.5V	1, 3	VCC		62	mA	1, 2, 3
ICCZ	Supply Current	VCC=5.5V, VINL=0.0V, VINH=5.5V	1, 3	VCC		48	mA	1, 2, 3
ICEX	Output HIGH Leakage Current	VCC=5.5V, VINL=0.0V, VINH=5.5V, VM=5.5V	1, 3	OUTPUTS		250	uA	1, 2, 3
IOZH	Output Leakage Current	VCC=5.5V, VM=2.7V, VIH=2.0V, VINH=5.5V, VINL=0.0V	1, 3	OUTPUTS		50	uA	1, 2, 3
IOZL	Output Leakage Current	VCC=5.5V, VM=0.5V, VIH=2.0V, VINH=5.5V, VIL=0.8V	1, 3	OUTPUTS		-50	uA	1, 2, 3

Electrical Characteristics

AC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)

AC: CL=50pf, RL=500 OHMS, TR=2.5ns, TF=2.5ns SEE AC FIGS

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
tpLH	Propagation Delay	VCC=5.0V @25C, VCC=4.5V & 5.5V @-55/125C	2, 4	In to On	2.5	6.0	ns	9
			2, 4	In to On	2.0	7.0	ns	10, 11
tpHL	Propagation Delay	VCC=5.0V @25C, VCC=4.5V & 5.5V @-55/125C	2, 4	In to On	2.5	6.0	ns	9
			2, 4	In to On	2.0	7.0	ns	10, 11
tpZH	Output Enable Time	VCC=5.0V @25C, VCC=4.5V & 5.5V @-55/125C	2, 4	\overline{OE} to On	2.5	8.0	ns	9
			2, 4	\overline{OE} to On	2.0	8.5	ns	10, 11
tpZL	Output Enable Time	VCC=5.0V @25C, VCC=4.5V & 5.5V @-55/125C	2, 4	\overline{OE} to On	2.5	8.0	ns	9
			2, 4	\overline{OE} to On	2.0	8.5	ns	10, 11
tpHZ	Disable Time	VCC=5.0V @25C, VCC=4.5V & 5.5V @-55/125C	2, 4	\overline{OE} to On	2.0	5.5	ns	9
			2, 4	\overline{OE} to On	1.5	6.5	ns	10, 11
tpLZ	Disable Time	VCC=5.0V @25C, VCC=4.5V & 5.5V @-55/125C	2, 4	\overline{OE} to On	2.0	7.0	ns	9
			2, 4	\overline{OE} to On	1.5	9.0	ns	10, 11

Note 1: Screen tested 100% on each device at +25C, +125C & -55C temperature, subgroups A1, 2, 3, 7 & 8.

Note 2: Screen tested 100% on each device at +25C temperature only, subgroup A9.

Note 3: Sample tested (Method 5005, Table 1) on each MFG. lot at +25C, +125C & -55C temperature, subgroups A1, 2, 3, 7 & 8.

Note 4: Sample tested (Method 5005, Table 1) on each MFG. lot at +25C subgroup A9, and periodically at +125C & -55C temperature, subgroups 10 & 11.